

# Search Notes



Application/Control No.

10/823,469

Examiner

Lan Nguyen

Applicant(s)/Patent under  
Reexamination

NAIK ET AL.

Art Unit

3683

## SEARCHED

Class	Subclass	Date	Examiner
303	122.07	9/23/05	XLN
Update		8/23/06	XLN

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
TEXT search included	9/23/05	XLN
update	8/23/06	XLN